

## General Description

The VSM80N07 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications.

## Features

- $V_{DS}=75V$ ;  $I_D=80A@V_{GS}=10V$ ;  
 $R_{DS(ON)}<8m\Omega @V_{GS}=10V$
- Special process technology for high ESD capability
- Special designed for converters and power controls
- High density cell design for ultra low  $R_{dson}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high  $E_{AS}$
- Excellent package for good heat dissipation

## Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



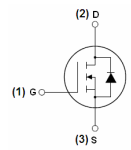
TO-220C

### Product Summary

$BV_{DSS}$	typ.	84	V
$R_{DS(ON)}$	typ.	6.5	m $\Omega$
	max.	8.0	m $\Omega$
$I_D$		80	A



TO-220-3L top view



Schematic Diagram

## Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM80N07-TC	VSM80N07	TO-220C	-	-	-

**Table 1. Absolute Maximum Ratings ( $T_C=25^\circ C$ )**

Parameter	Symbol	Value	Unit
Drain-Source Voltage ( $V_{GS}=0V$ )	$V_{DS}$	75	V
Gate-Source Voltage ( $V_{DS}=0V$ )	$V_{GS}$	$\pm 25$	V
Drain Current (DC) at $T_C=25^\circ C$	$I_{D(DC)}$	80	A
Drain Current (DC) at $T_C=100^\circ C$	$I_{D(DC)}$	60	A
Drain Current-Continuous@ Current-Pulsed (Note 1)	$I_{DM(pluse)}$	320	A
Peak diode recovery voltage	$dv/dt$	30	V/ns
Maximum Power Dissipation( $T_C=25^\circ C$ )	$P_D$	170	W
Derating factor		1.13	W/ $^\circ C$
Single pulse avalanche energy (Note 2)	$E_{AS}$	580	mJ
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 175	$^\circ C$

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2.EAS condition :  $T_J=25^\circ C, V_{DD}=50V, V_G=10V, L=0.3mH, I_D=62A$ ;

**Table 2. Thermal Characteristic**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Maximum)	$R_{thJC}$	0.88	$^{\circ}C/W$
Thermal Resistance, Junction-to-Ambient (Maximum)	$R_{thJA}$	63	$^{\circ}C/W$

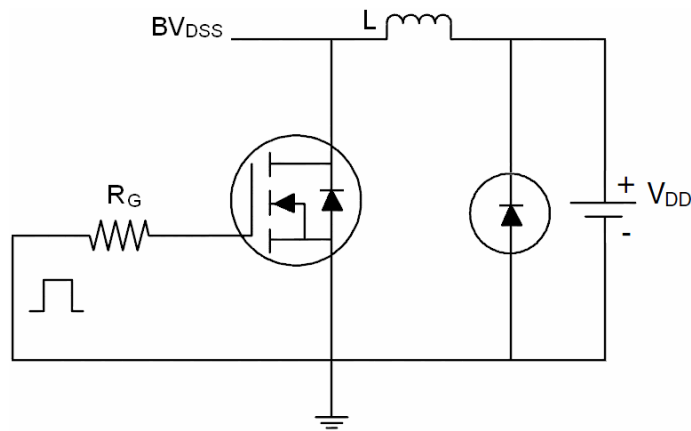
**Table 3. Electrical Characteristics ( $T_C=25^{\circ}C$  unless otherwise noted)**

Parameter	Symbol	Condition	Min	Typ	Max	Unit
On/off states						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	75	84		V
Zero Gate Voltage Drain Current(Tc=25℃)	I <sub>DSS</sub>	V <sub>DS</sub> =75V,V <sub>GS</sub> =0V			1	μA
Zero Gate Voltage Drain Current(Tc=125℃)	I <sub>DSS</sub>	V <sub>DS</sub> =75V,V <sub>GS</sub> =0V			10	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	2	2.85	4	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =40A		6.5	8	mΩ
Dynamic Characteristics						
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =10V,I <sub>D</sub> =40A	20	-	-	S
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =25V,V <sub>GS</sub> =0V, F=1.0MHz		4400		PF
Output Capacitance	C <sub>oss</sub>			340		PF
Reverse Transfer Capacitance	C <sub>rss</sub>			260		PF
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =30V,I <sub>D</sub> =30A, V <sub>GS</sub> =10V		100		nC
Gate-Source Charge	Q <sub>gs</sub>			20		nC
Gate-Drain Charge	Q <sub>gd</sub>			30		nC
Switching times						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =30V,I <sub>D</sub> =2A,R <sub>L</sub> =15Ω V <sub>GS</sub> =10V,R <sub>G</sub> =2.5Ω		17.8		nS
Turn-on Rise Time	t <sub>r</sub>			11.8		nS
Turn-Off Delay Time	t <sub>d(off)</sub>			56		nS
Turn-Off Fall Time	t <sub>f</sub>			14.6		nS
Source- Drain Diode Characteristics						
Source-drain current(Body Diode)	I <sub>SD</sub>				80	A
Pulsed Source-drain current(Body Diode)	I <sub>SDM</sub>				320	A
Forward on voltage <sup>(Note 1)</sup>	V <sub>SD</sub>	T <sub>j</sub> =25℃,I <sub>SD</sub> =40A,V <sub>GS</sub> =0V			1.2	V
Reverse Recovery Time <sup>(Note 1)</sup>	t <sub>rr</sub>	T <sub>j</sub> =25℃,I <sub>F</sub> =75A,di/dt=100A/μs			36	nS
Reverse Recovery Charge <sup>(Note 1)</sup>	Q <sub>rr</sub>				56	nC
Forward Turn-on Time	t <sub>on</sub>	Intrinsic turn-on time is negligible(turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )				

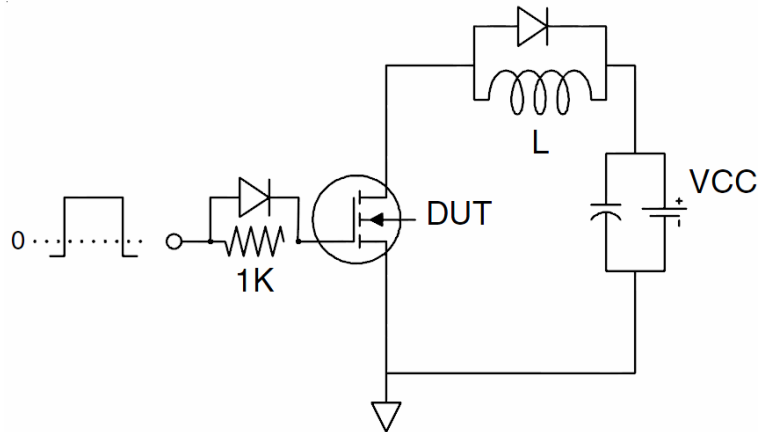
Notes 1. Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 1.5\%$ ,  $R_G=25\Omega$ , Starting  $T_J=25^{\circ}C$

## Test Circuit

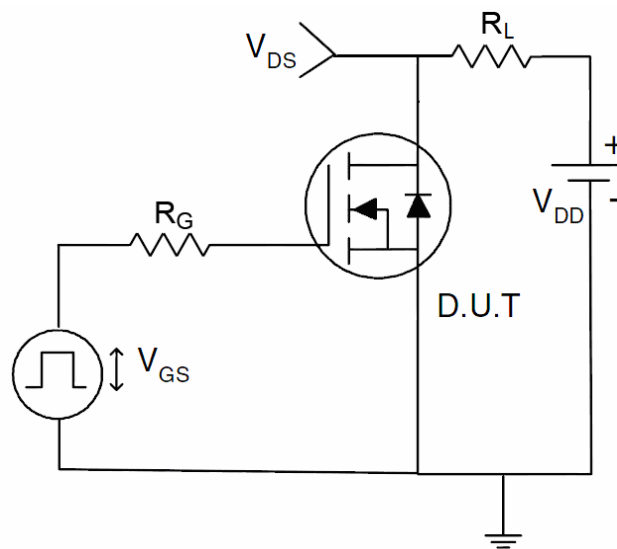
### 1) $E_{AS}$ Test Circuit



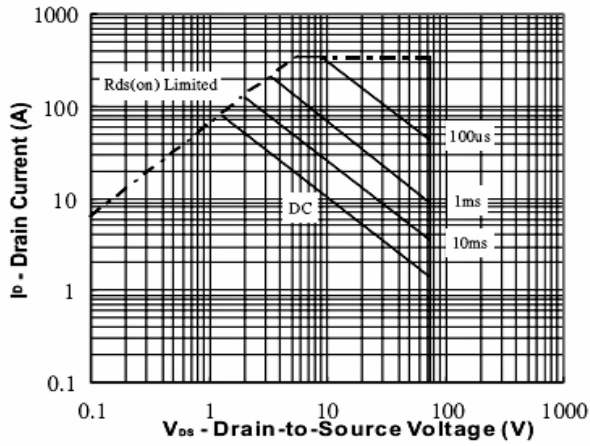
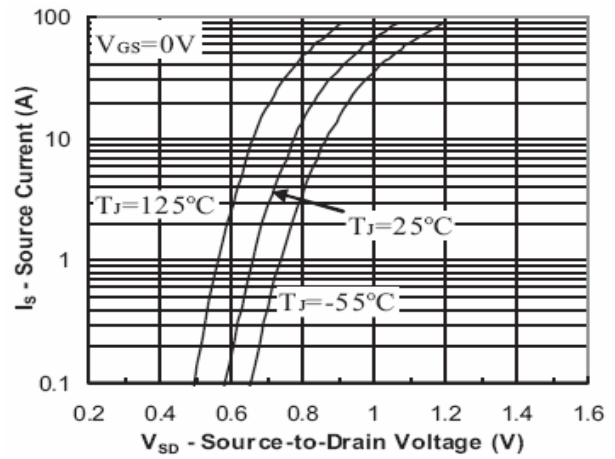
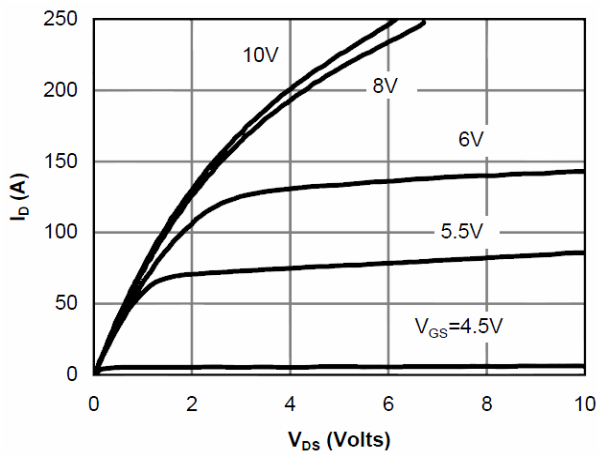
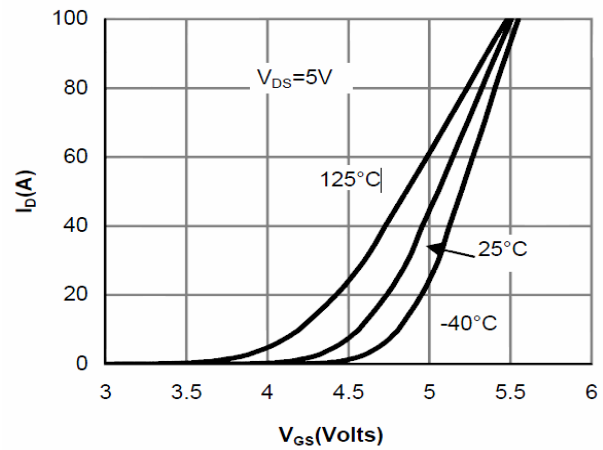
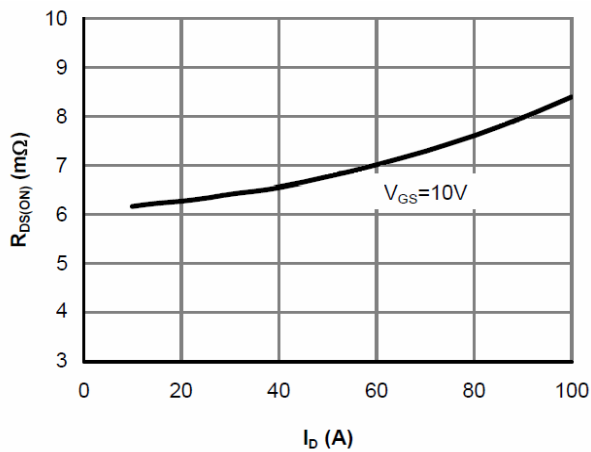
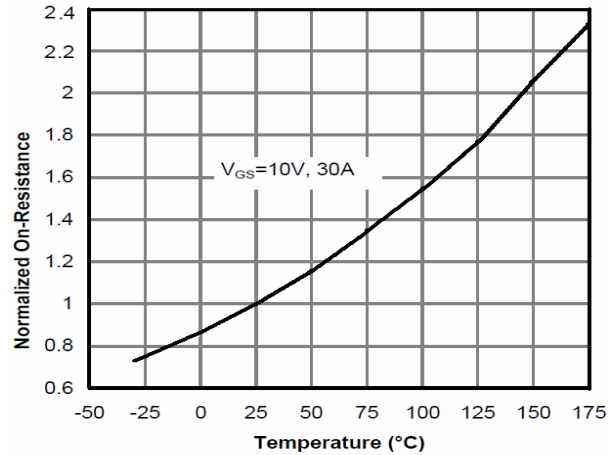
### 2) Gate Charge Test Circuit

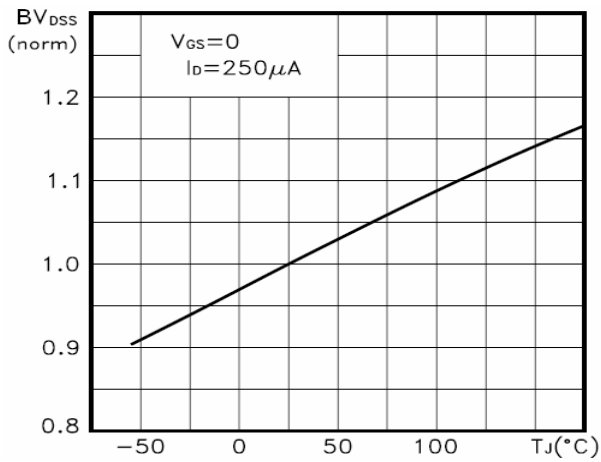
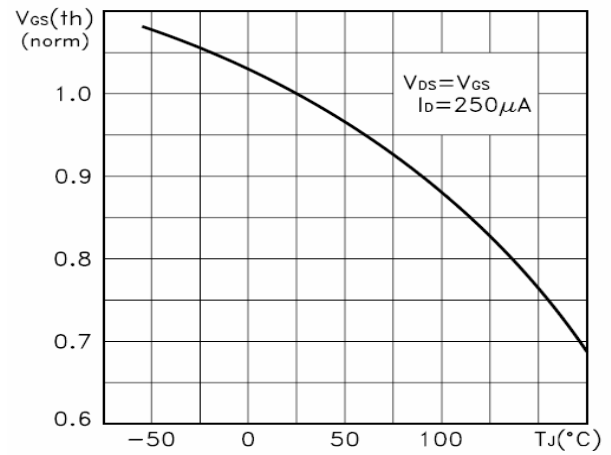
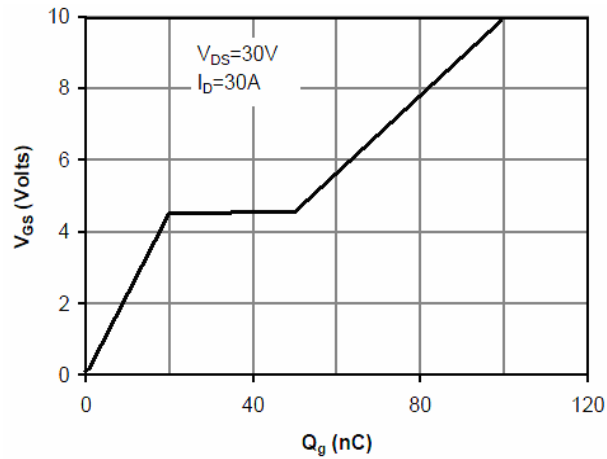


### 3) Switch Time Test Circuit



## Typical Electrical and Thermal Characteristics (curves)

**Figure1. Safe operating area**

**Figure2. Source-Drain Diode Forward Voltage**

**Figure3. Output characteristics**

**Figure4. Transfer characteristics**

**Figure5. Static drain-source on resistance**

**Figure6.  $R_{DS(ON)}$  vs Junction Temperature**


**Figure7.  $BV_{DSS}$  vs Junction Temperature**

**Figure8.  $V_{GS(th)}$  vs Junction Temperature**

**Figure9. Gate charge waveforms**

**Figure10. Capacitance**
